

MOTOROLA SC (DIODES/OPTO) 25E D ■ 6367255 0080965 1 ■ T-25-09

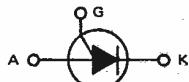
Silicon Programmable Unijunction Transistors

...designed to enable the engineer to "program" unijunction characteristics such as R_{BB} , η , I_V , and I_P by merely selecting two resistor values. Application includes thyristor-trigger, oscillator, pulse and timing circuits. These devices may also be used in special thyristor applications due to the availability of an anode gate.

- Programmable — R_{BB} , η , I_V and I_P
- Hermetic TO-18 Package
- Low On-State Voltage — 1.5 Volts Maximum @ $I_F = 50$ mA
- Low Gate to Anode Leakage Current — 5 nA Maximum
- High Peak Output Voltage — 16 Volts Typical
- Low Offset Voltage — 0.35 Volt Typical ($R_G = 10$ k ohms)

**2N6116
2N6117
2N6118**

**PUTs
40 VOLTS — 250 mW**



CASE 22-03
(TO-18)
STYLE 6

*MAXIMUM RATINGS

3

Rating	Symbol	Value	Unit
Repetitive Peak Forward Current 100 μ s Pulse Width, 1% Duty Cycle 20 μ s Pulse Width, 1% Duty Cycle	I_{TRM}	1 2	Amps
Non-Repetitive Peak Forward Current 10 μ s Pulse Width	I_{TSM}	5	Amps
DC Forward Anode Current Derate Above 25°C	I_T	200 2	mA mA°C
DC Gate Current	I_G	± 20	mA
Gate to Cathode Forward Voltage	V_{GKF}	40	Volts
Gate to Cathode Reverse Voltage	V_{GKR}	5	Volts
Gate to Anode Reverse Voltage	V_{GAR}	40	Volts
Anode to Cathode Voltage	V_{AK}	± 40	Volts
Forward Power Dissipation @ $T_A = 25^\circ\text{C}$ Derate Above 25°C	P_F $1/\theta_JA$	250 2.5	mW mW°C
Operating Junction Temperature Range	T_J	-55 to +125	°C
Storage Temperature Range	T_{stg}	-65 to +200	°C

*Indicates JEDEC Registered Data.

MOTOROLA THYRISTOR DEVICE DATA

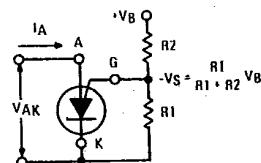
T-25-09

***ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)**

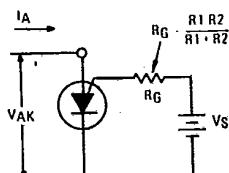
Characteristic	Fig. No.	Symbol	Min	Typ	Max	Unit
Offset Voltage ($V_S = 10$ Vdc, $R_G = 1$ MΩ) ($V_S = 10$ Vdc, $R_G = 10$ k ohms)	2N6116 2N6117 2N6118 All Types	1	VT	0.2 0.2 0.2 0.2	0.70 0.50 0.40 0.35	1.6 0.6 0.6 0.6
Gate to Anode Leakage Current ($V_S = 40$ Vdc, $T_A = 25^\circ\text{C}$, Cathode Open) ($V_S = 40$ Vdc, $T_A = 75^\circ\text{C}$, Cathode Open)	—	I_{GAO}	— —	1 30	5 75	nA/dc
Gate to Cathode Leakage Current ($V_S = 40$ Vdc, Anode to Cathode Shorted)	—	I_{GKS}	—	5	50	nA/dc
Peak Current ($V_S = 10$ Vdc, $R_G = 1$ MΩ) ($V_S = 10$ Vdc, $R_G = 10$ k ohms)	2N6116 2N6117 2N6118 2N6116 2N6117 2N6118	2,9,14	I_P	— — — — — —	1.25 0.19 0.08 4 1.20 0.70	2 0.3 0.16 5 2 1
Valley Current ($V_S = 10$ Vdc, $R_G = 1$ MΩ) ($V_S = 10$ Vdc, $R_G = 10$ k ohms)	2N6116, 2N6117 2N6118 2N6116 2N6117, 2N6118	1,4,5	I_V	— — 70 50	18 18 270 270	50 25 — —
Forward Voltage ($I_F = 50$ mA Peak)	1,6	V_F	—	0.8	1.5	Volts
Peak Output Voltage ($V_B = 20$ Vdc, $C_C = 0.2$ μF)	3,7	V_O	6	16	—	Volts
Pulse Voltage Rise Time ($V_B = 20$ Vdc, $C_C = 0.2$ μF)	3	t_r	—	40	80	ns

*Indicates JEDEC Registered Data.

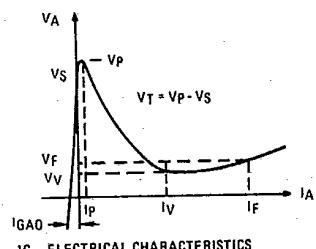
FIGURE 1 – ELECTRICAL CHARACTERIZATION



**IA - PROGRAMMABLE UNIJUNCTION
WITH "PROGRAM" RESISTORS
81 and 82**



**1B - EQUIVALENT TEST CIRCUIT FOR
FIGURE 1A USED FOR ELECTRICAL
CHARACTERISTICS TESTING
(ALSO SEE FIGURE 2)**



1C – ELECTRICAL CHARACTERISTICS

FIGURE 2 – PEAK CURRENT (I_p) TEST CIRCUIT

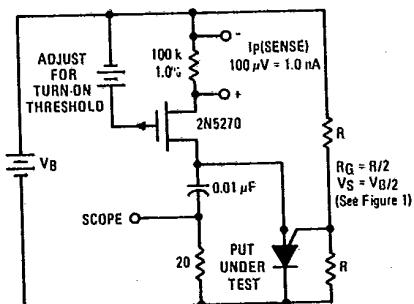
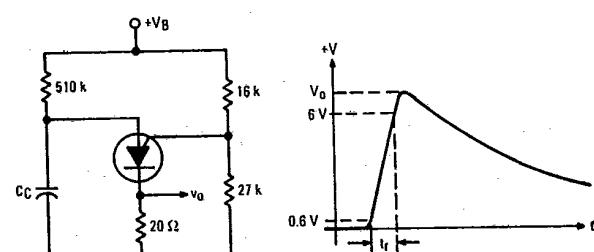


FIGURE 3 – V_o AND t_r TEST CIRCUIT



MOTOROLA THYRISTOR DEVICE DATA

MOTOROLA SC (DIODES/OPTO) 25E D ■ 6367255 0080967 5 ■
 2N6116 • 2N6117 • 2N6118
 TYPICAL VALLEY CURRENT BEHAVIOR

T-25-09

FIGURE 4 - EFFECT OF SUPPLY VOLTAGE

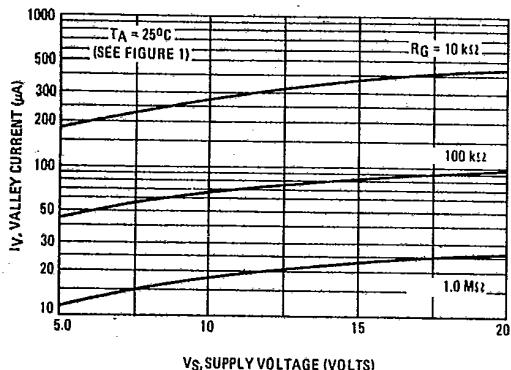


FIGURE 5 - EFFECT OF TEMPERATURE

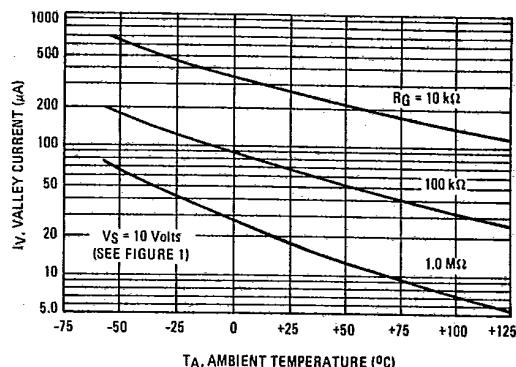


FIGURE 6 - FORWARD VOLTAGE

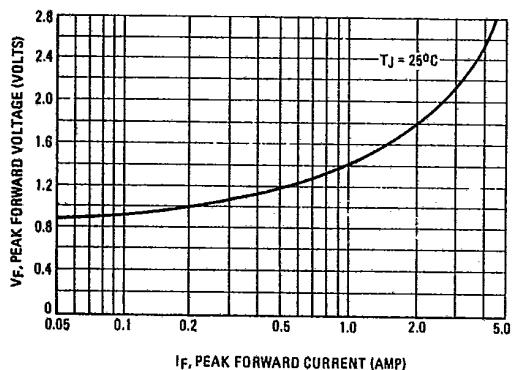
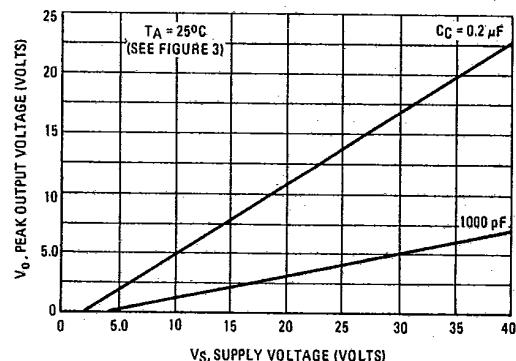
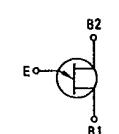


FIGURE 7 - PEAK OUTPUT VOLTAGE

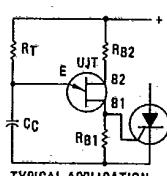
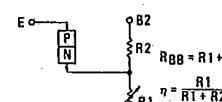


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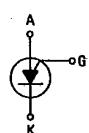
FIGURE 8 - STANDARD UNIJUNCTION COMPARED TO PROGRAMMABLE UNIJUNCTION



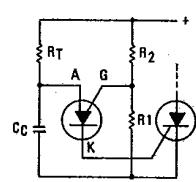
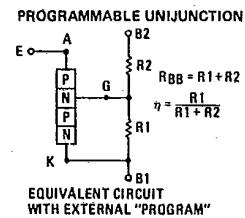
STANDARD UNIJUNCTION



CIRCUIT SYMBOL



PROGRAMMABLE UNIJUNCTION



MOTOROLA SC (DIODES/OPTO) 2SE D ■ 6367255 0080968 7 ■

2N6116 • 2N6117 • 2N6118

T-25-09

TYPICAL PEAK CURRENT BEHAVIOR

2N6116

FIGURE 9 – EFFECT OF SUPPLY VOLTAGE AND R_G

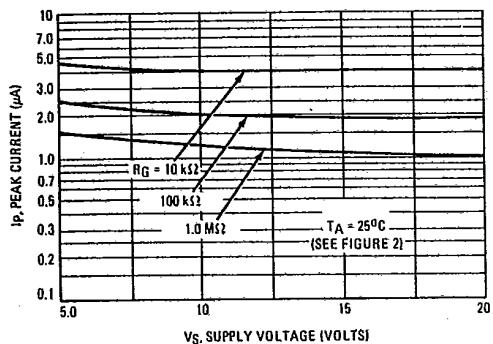
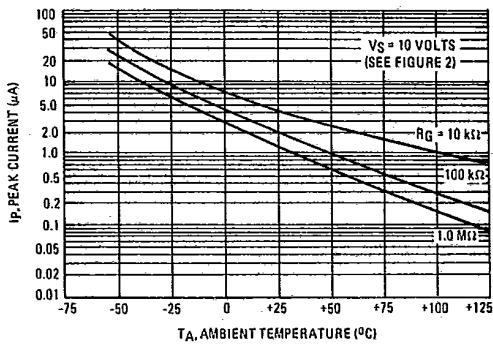


FIGURE 10 – EFFECT OF TEMPERATURE AND R_G



2N6117

FIGURE 11 – EFFECT OF SUPPLY VOLTAGE AND R_G

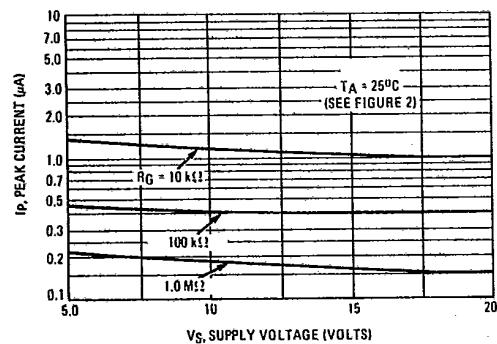
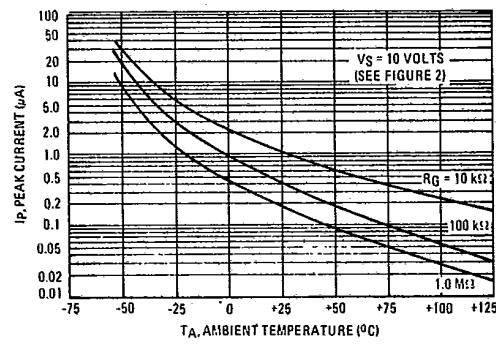


FIGURE 12 – EFFECT OF TEMPERATURE AND R_G



3

2N6118

FIGURE 13 – EFFECT OF SUPPLY VOLTAGE AND R_G

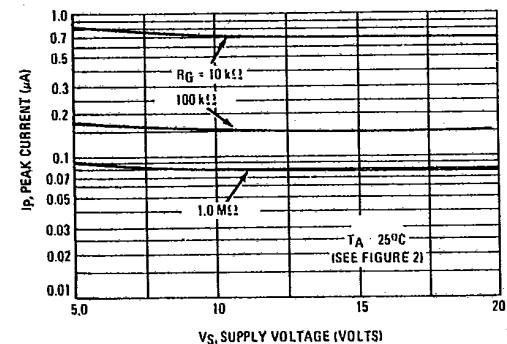
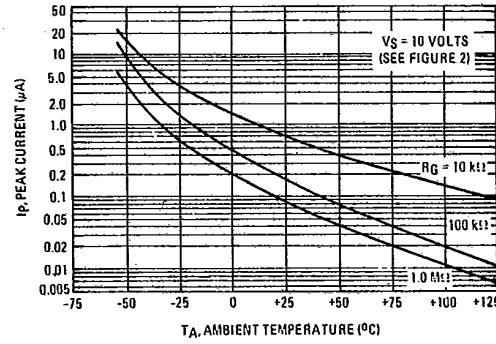


FIGURE 14 – EFFECT OF TEMPERATURE AND R_G



MOTOROLA THYRISTOR DEVICE DATA